Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10622294	CHOWN, DAVID
Examiner	Art Unit
Liu, Li	2613

SEARCHED			
Class	Subclass	Date	Examiner
372	102	08/03/2006	LL
398	41-43, 152, 129, 58, 122, 125	08/03/2006, 02/08/2007	LL
385	12, 24, 93, 49	08/03/2006, 02/08/2007	LL
250	25	08/03/2006	LL

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST			
USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	08/03/2006, 02/08/2007, 11/27/2007, 5/31-6/13, 2008; 12/29-12/30, 2008; 6/8 & 6/9, 2009	LL	
Google	08/03/2006	LL	
IEEE	08/03/2006, 12/30/2008	LL	

	INTERFERENCE SEA	RCH	
Class	Subclass	Date	Examiner

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